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PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Shunichiro Tanigawa et al.

Serial No.: 10/816,626

Filed: April 2, 2004

For: CORRECTION COEFFICIENT
CALCULATING METHOD FOR X-RAY CT
SYSTEMS, BEAM HARDENING POST-
PROCESSING METHOD THEREFOR, AND
X-RAY CT SYSTEM

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: Art Unit: 2882
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: Examiner: Kao, Chih Cheng G.
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RESPONSE

Mail stop: AMENDMENT
Hon. Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

In response to the Office Action dated May 5, 2006, please consider the following remarks.